Coil on Module chip technology is growingly popular for dual interface card production.

Connected to the US-CLT Smartware Contactless tester, the Coil On Module Testing solution allows Functional Test and (Pre)Personalization, O.S. Loading of the CoM Chip Module directly on the Module Tape Handler.

Up to 32 Coil on Module chips can be tested in parallel during one machine cycle.

Smartware’s 32 positions CoM Testing Plate doesn’t require deep Module Handler modification or upgrade. The CoM Testing Plate just have to be fixed on the top of the 35mm tape path of none metallic guiding rail.

Both 9.5 or 14.25 mm Smartware Coil On Module testing plate are available.